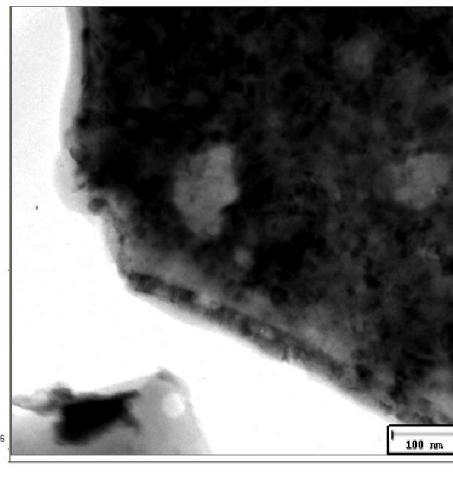
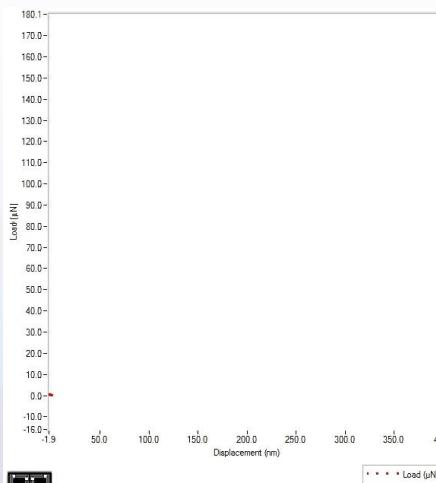
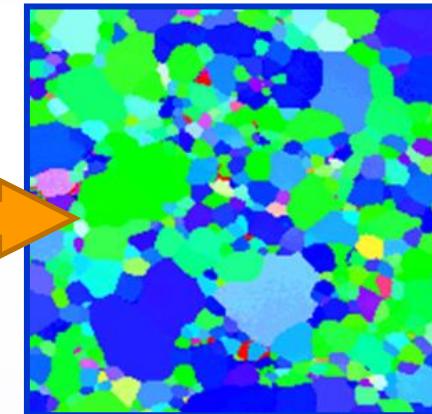
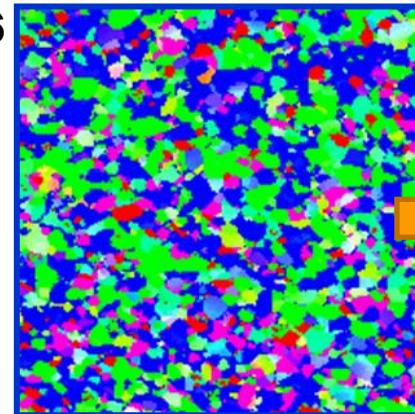
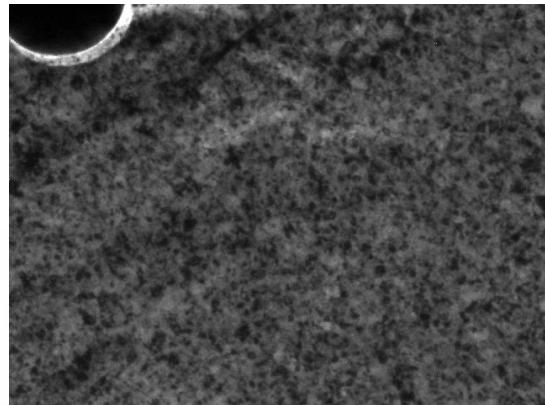


Exploring the Thermal, Mechanical, and Radiation Stability of Nanocrystalline Metals via *In situ* TEM

SAND2016-4807C

K. Hattar, D.C. Bufford, & B.R. Muntifering
Sandia National Laboratories

May 30, 2016



HYSITRON™

This work was supported by the US Department of Energy, Office of Basic Energy Sciences.

Sandia National Laboratories is a multi-program laboratory managed and operated by Sandia Corporation, a wholly owned subsidiary of Lockheed Martin Corporation, for the U.S. Department of Energy's National Nuclear Security Administration under contract DE-AC04-94AL85000.

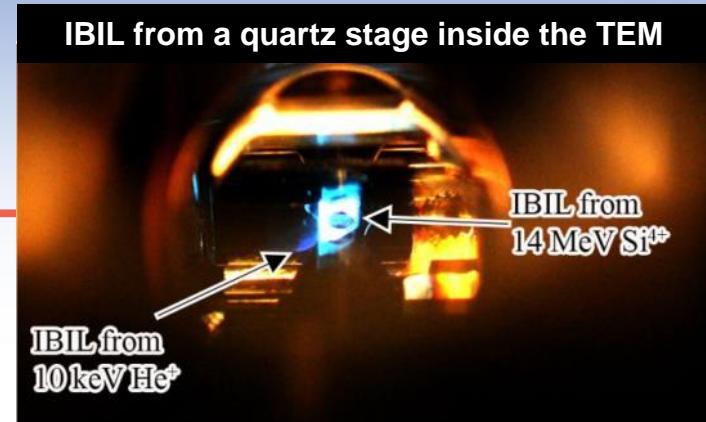
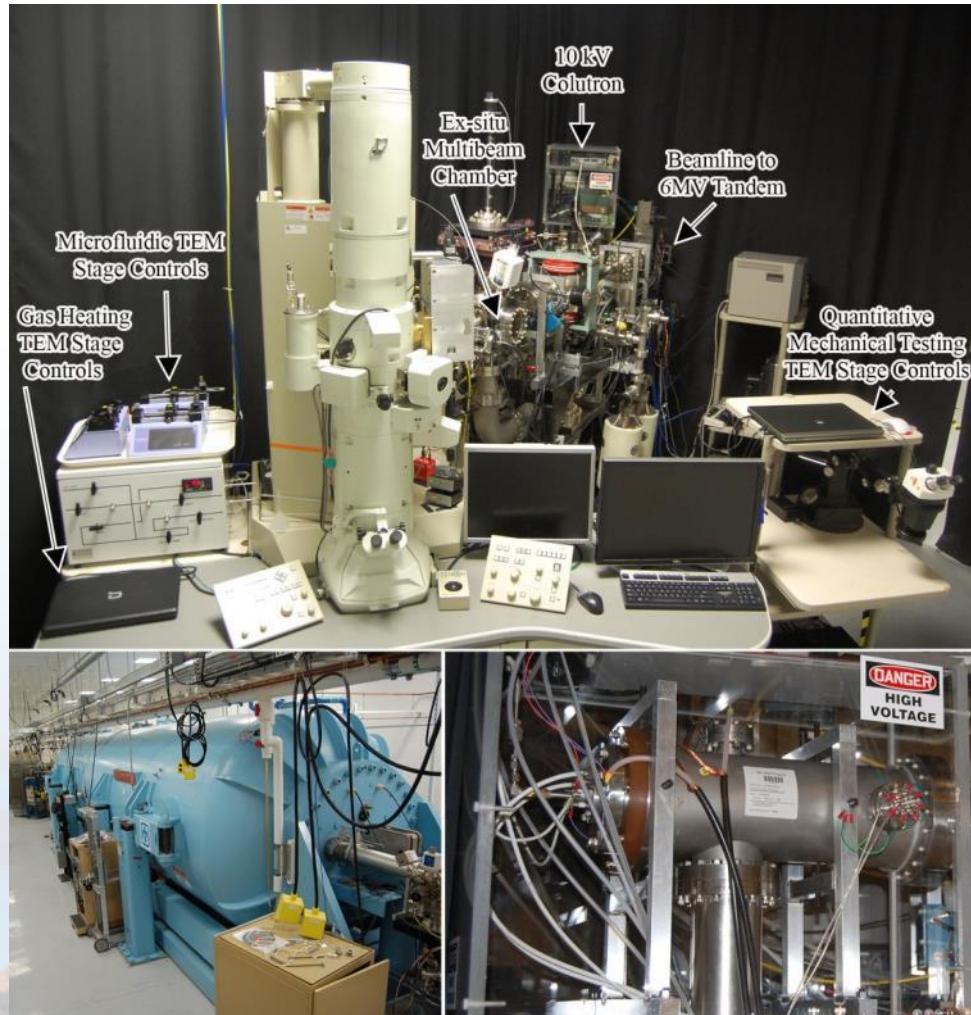


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Sandia's Concurrent *In situ* Ion Irradiation TEM Facility

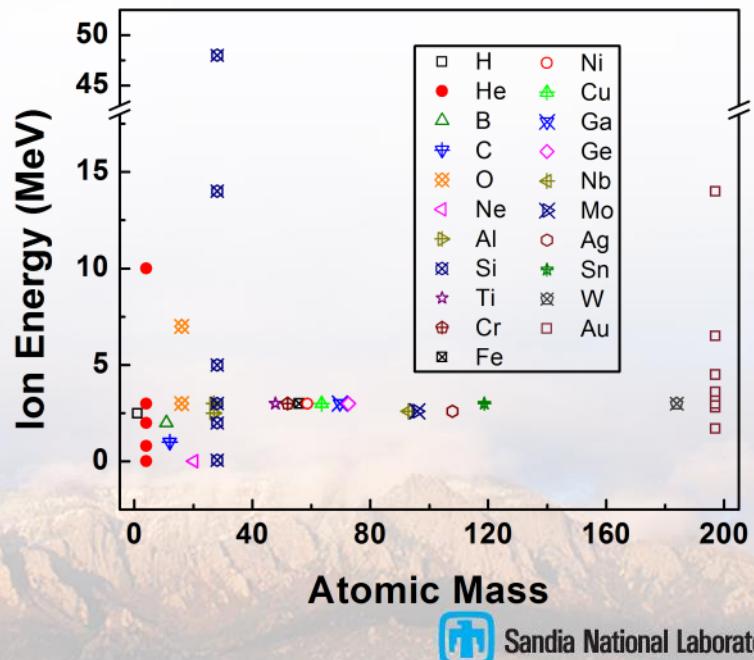
Collaborator: D.L. Buller

10 kV Colutron - 200 kV TEM - 6 MV Tandem



Direct real time observation
of ion irradiation,
ion implantation, or both
with nanometer resolution

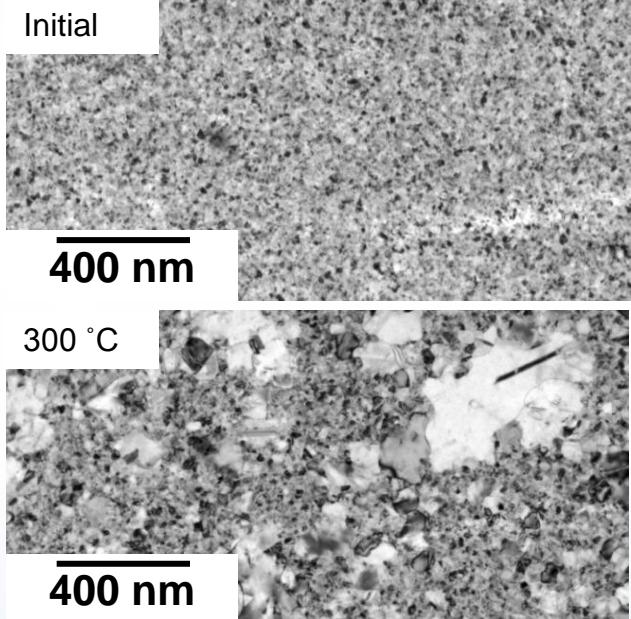
Ion species & energy introduced into the TEM



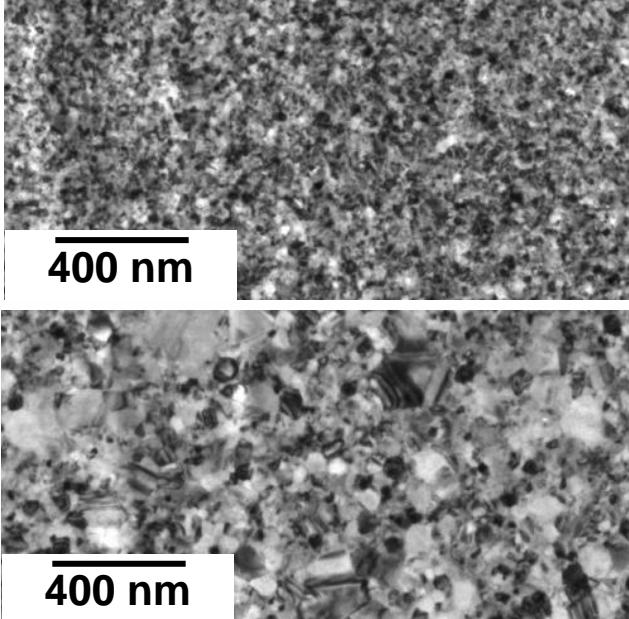
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Limitations of Classical Grain Size Analysis during *In situ* TEM Experiments

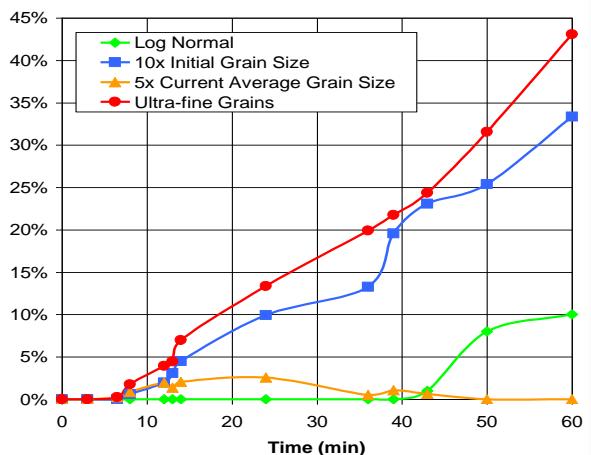
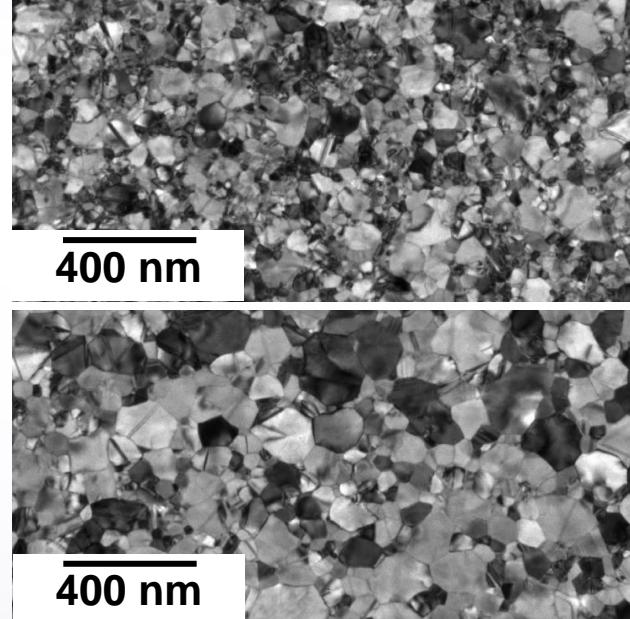
PLD Ni



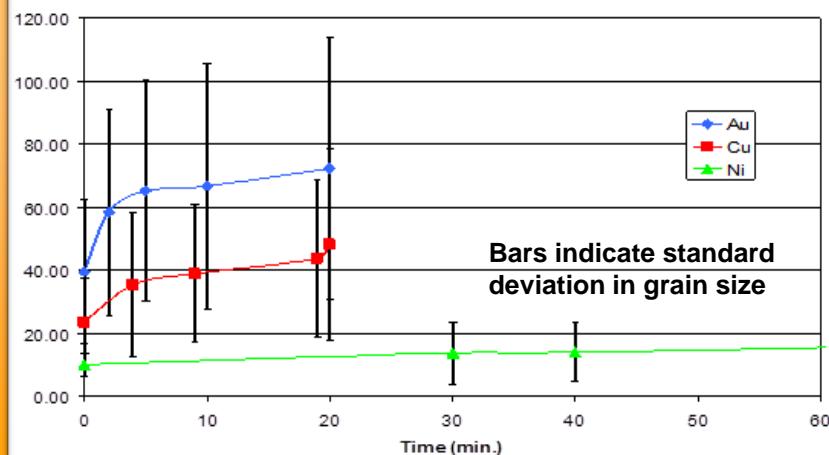
PLD Cu



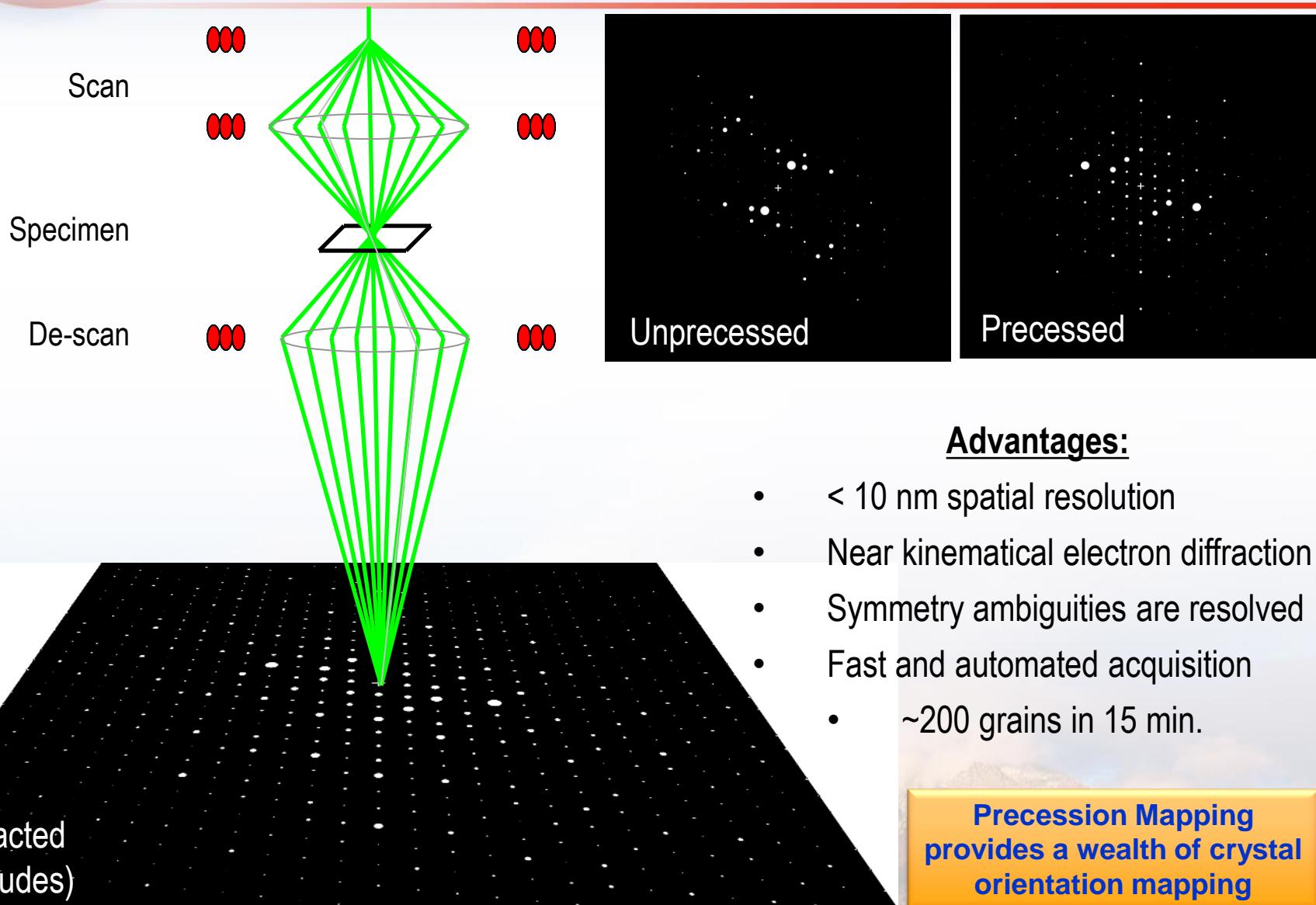
PLD Au



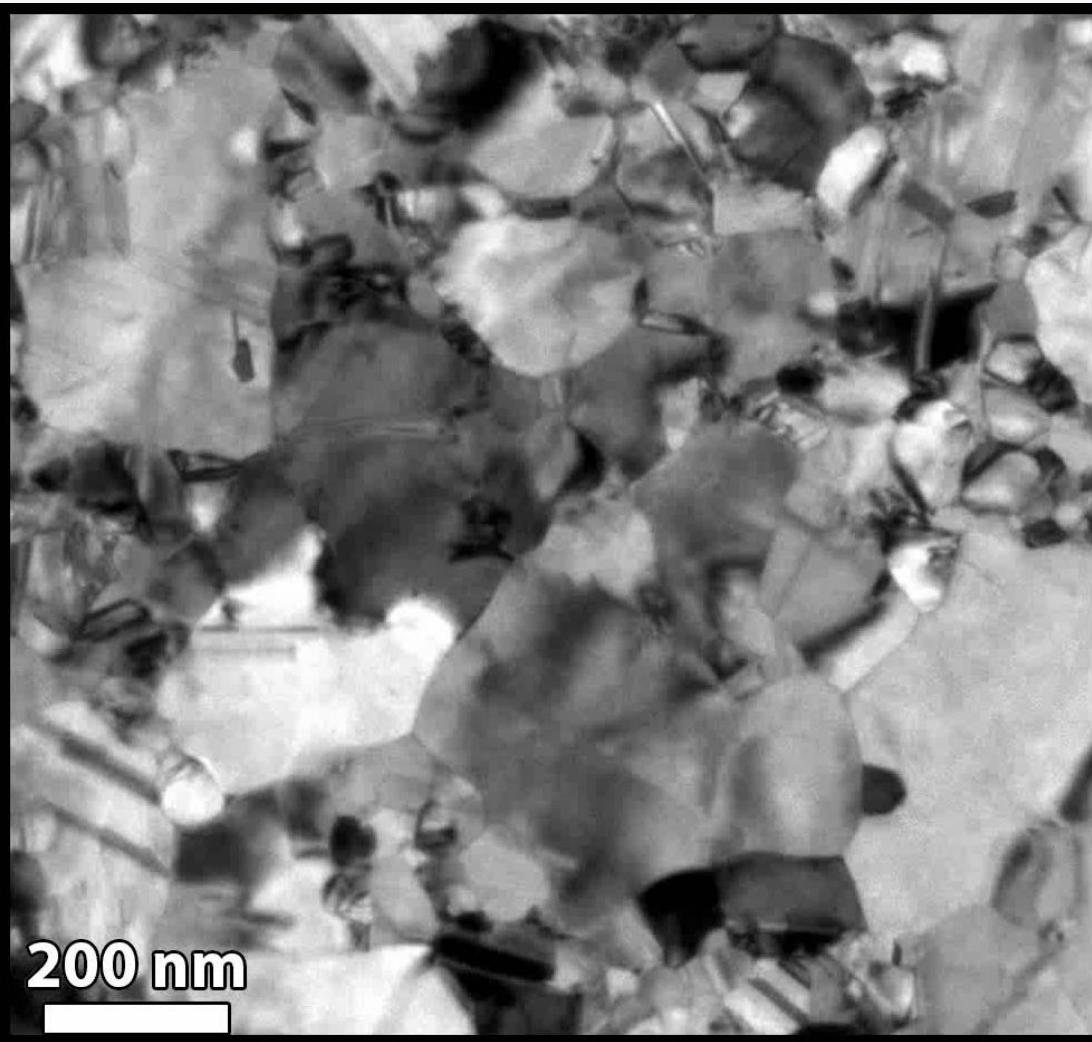
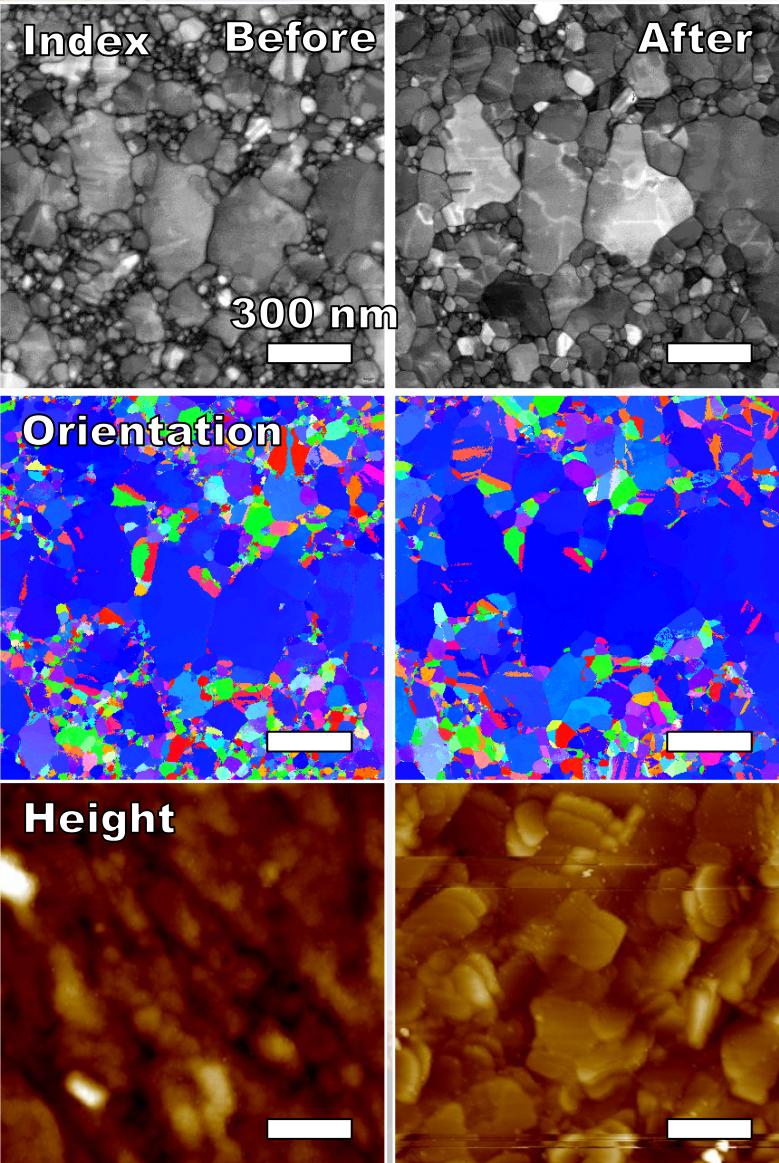
Classical line intercept analysis provides insight into grain size and distribution, but is time intensive and provides little analysis of texture and grain boundary character



Precession Electron Diffraction Microscopy



Initial Exploration into the Role of Texture and Surface Roughness on Abnormal Grain Growth Mechanisms



PED and AFM permit insight into texture, GB character, and surface roughness role on abnormal grain growth

In situ Quantitative Mechanical Testing

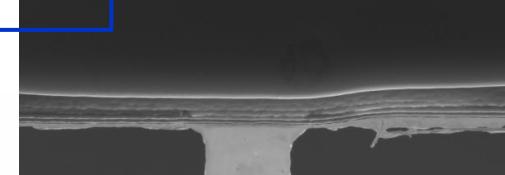


Hysitron PI95 *In Situ* Nanoindentation TEM Holder

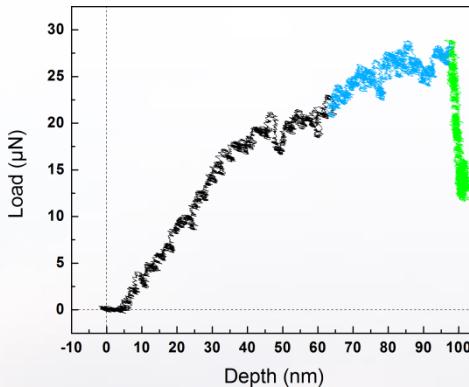
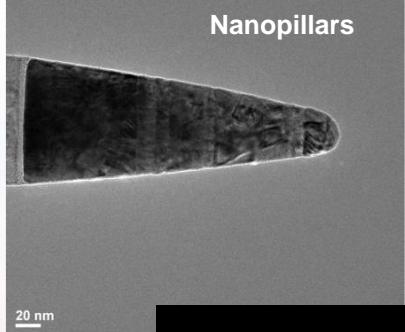
- Sub nanometer displacement resolution
- Quantitative force information with μN resolution
- **Concurrent real-time imaging by TEM**



Micro Tension Bars



Nanoindentation



500 nm

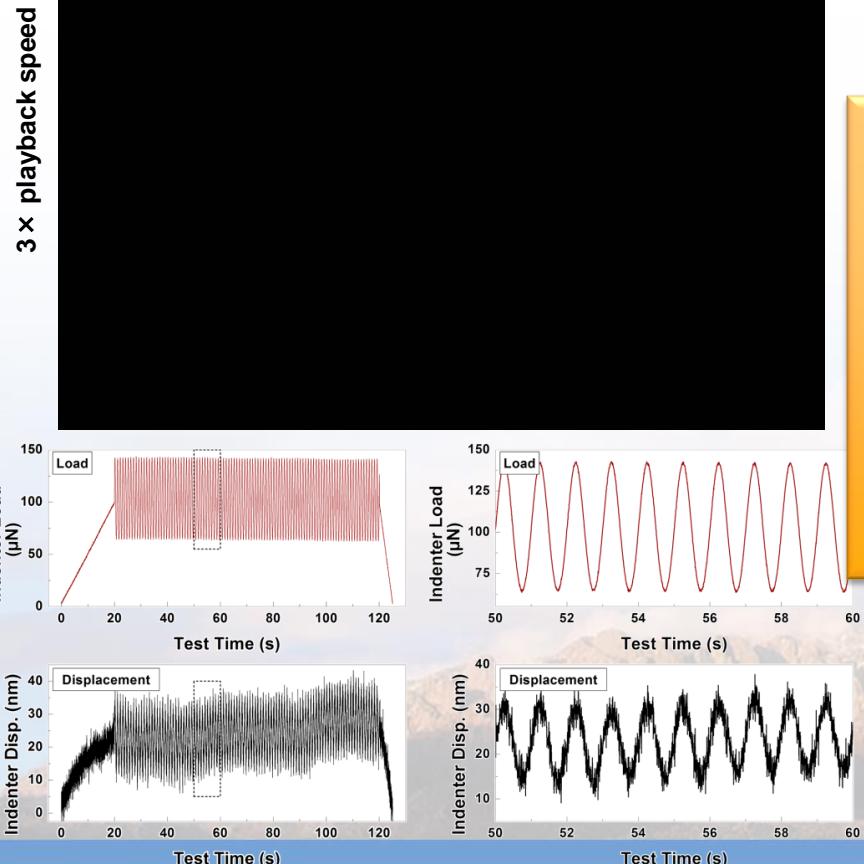
A bright-field TEM image of a nanopillar, showing its cylindrical shape and surface texture. A scale bar indicates 500 nm.

A range of mechanical testing of nanoscale geometries are possible.



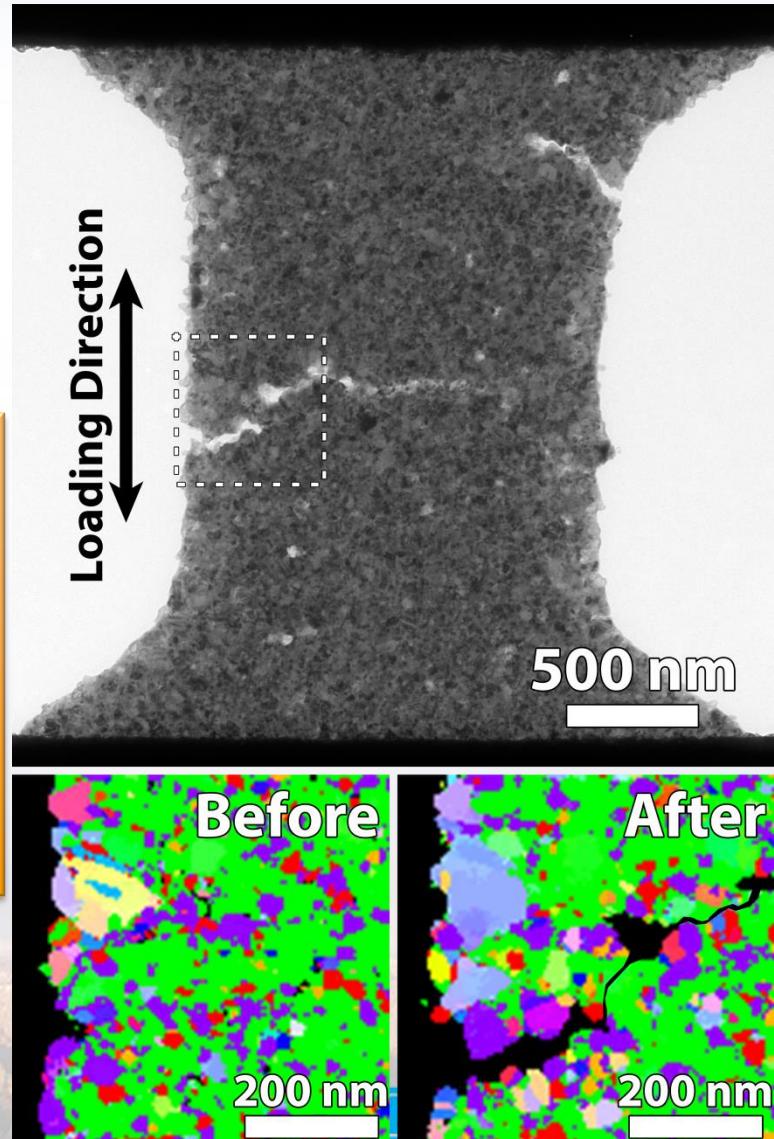
In situ TEM Quantitative Fatigue Testing

Contributors: D.C. Bufford, D. Stauffer, W. Mook



High cycle fatigue in real time with nanometer resolution

Reveals abnormal grain growth ahead of a crack tip



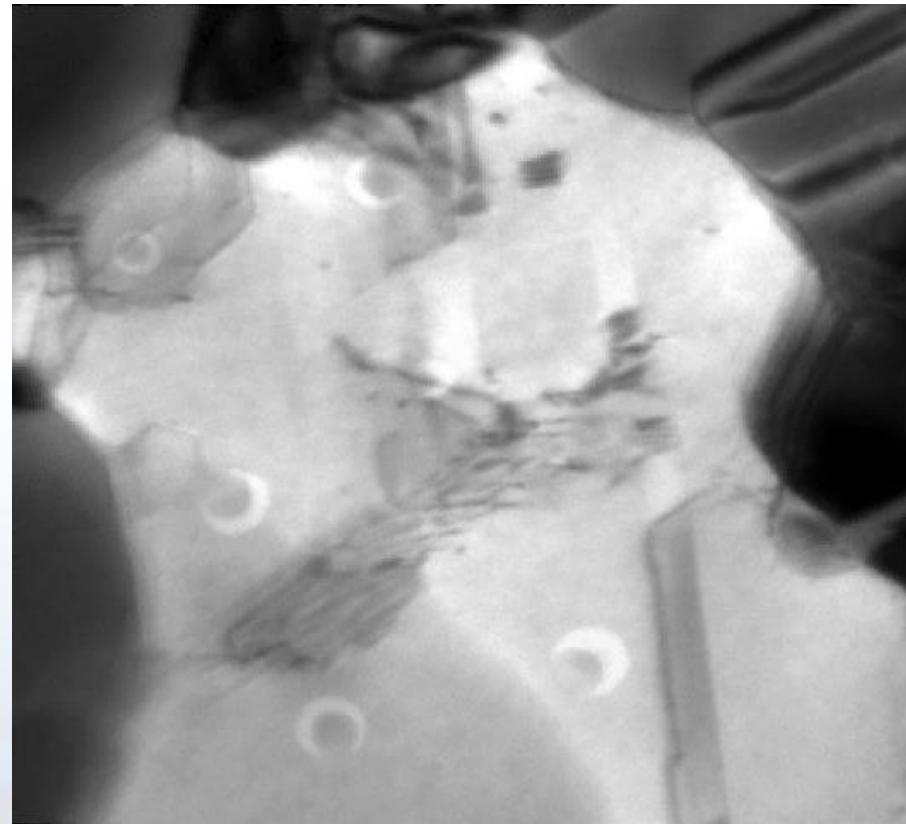


Dose Rate Effects

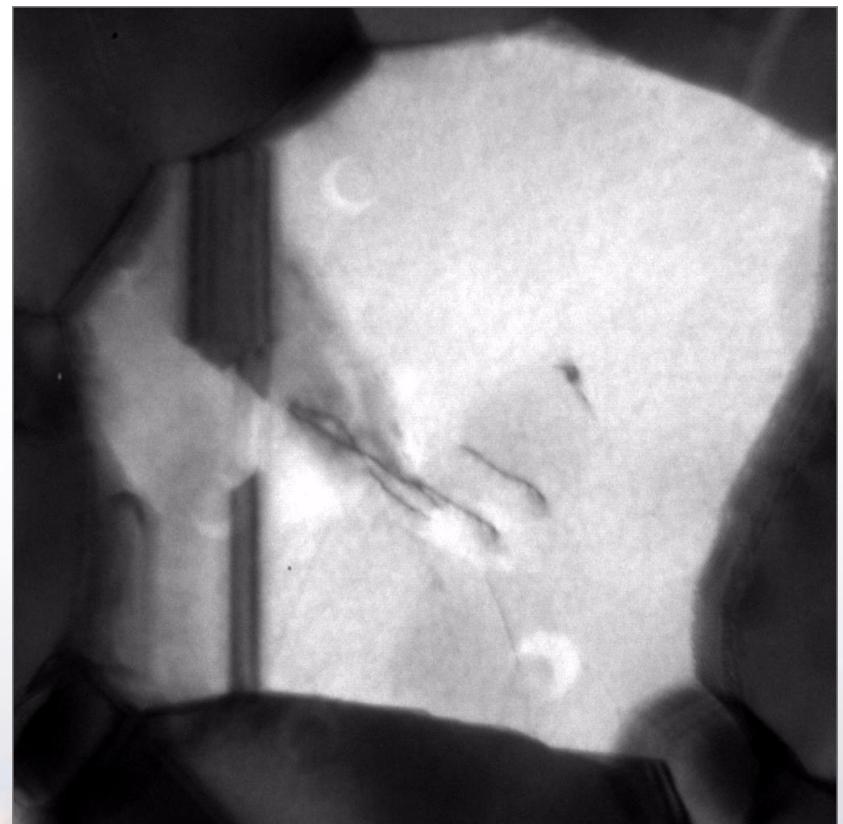
Collaborators: C. Chisholm, P. Hosemann, & A. Minor

7.9×10^9 ions/cm²/s

6.7×10^7 ions/cm²/s



VS



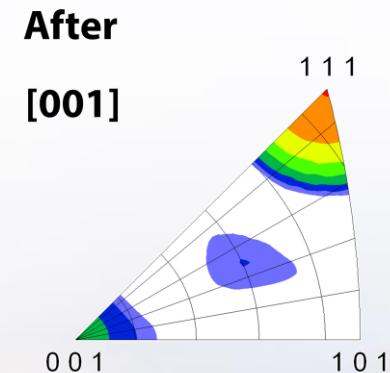
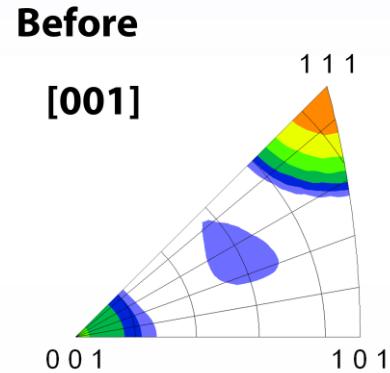
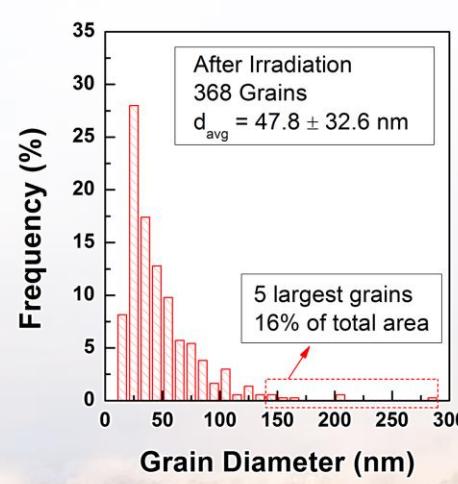
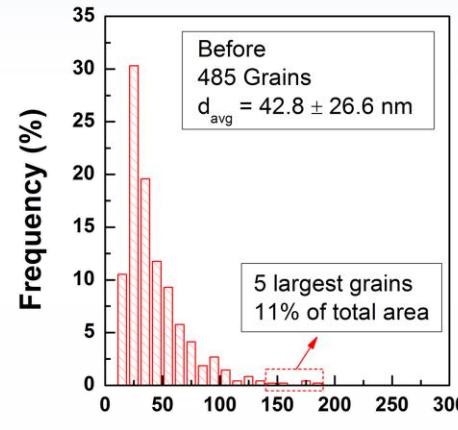
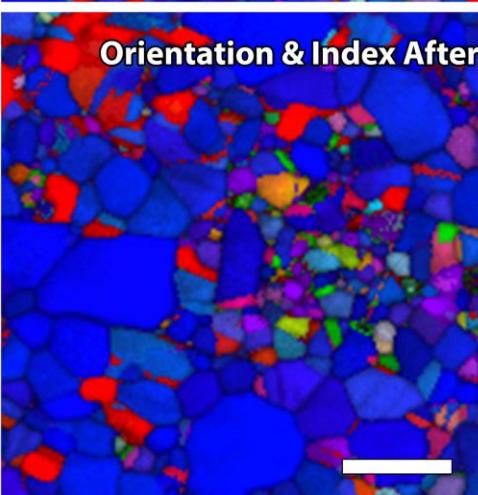
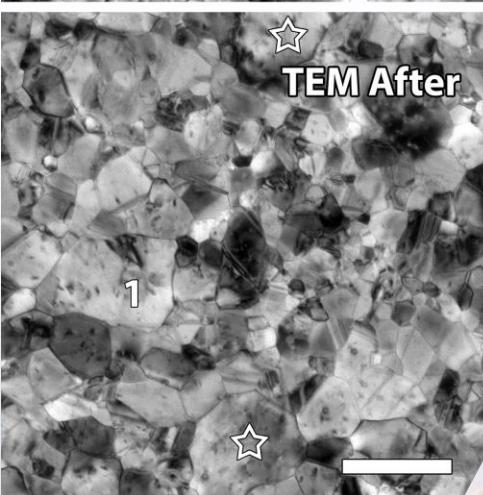
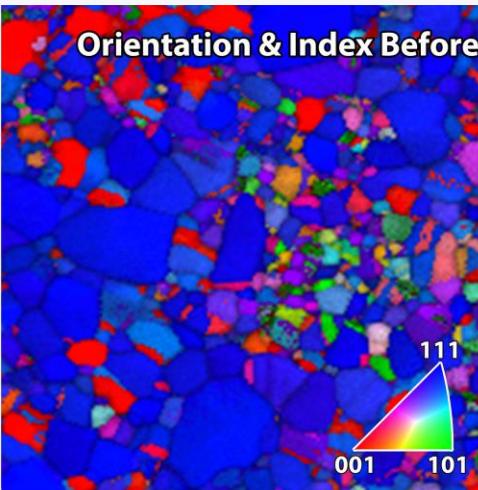
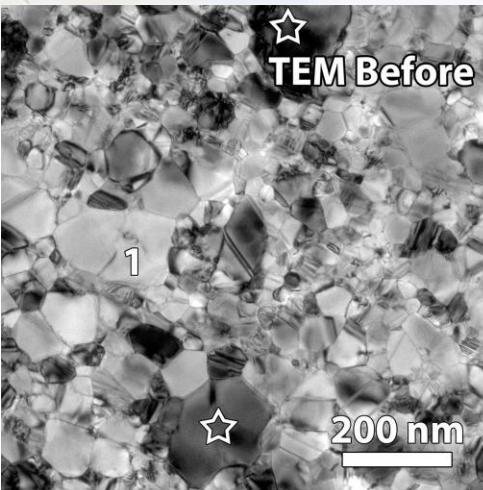
Single Ion strikes and the resulting microstructural evolution
can be directly observed with the I³TEM



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Quantifying Stability of Nanocrystalline Au during 10 MeV Si Ion Irradiation

Collaborators: F. Abdeljawad, & S.M. Foiles



Increasing Intensity



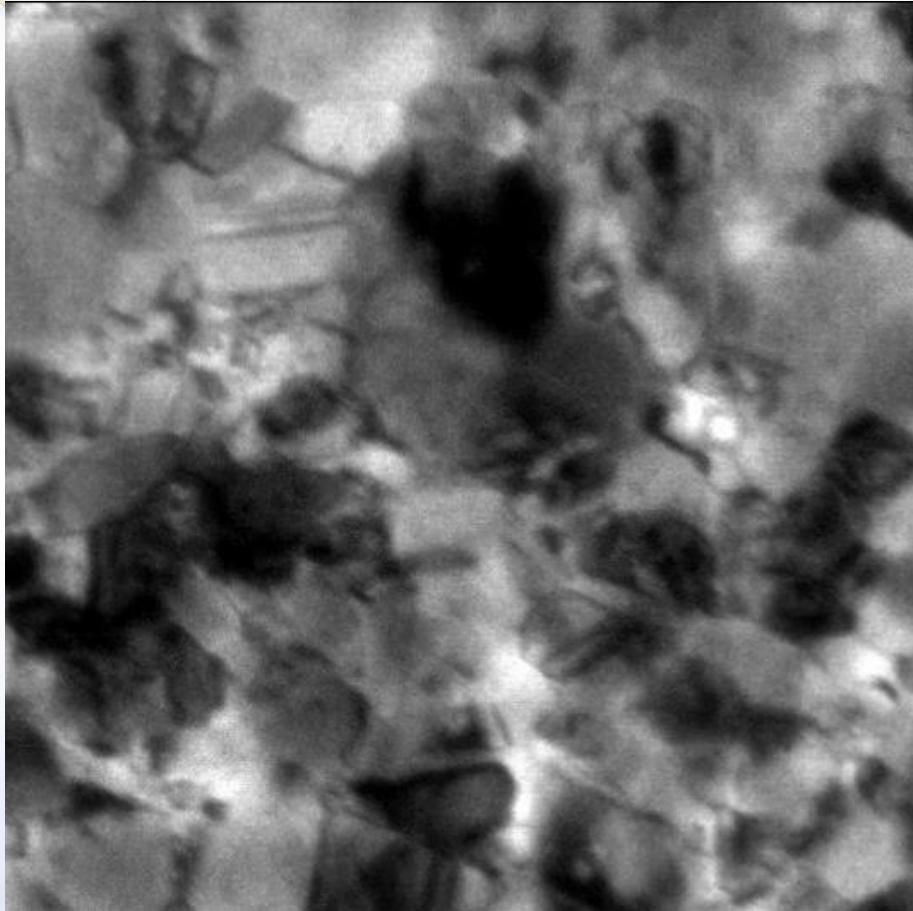
Any texture or grain boundary evolution can be directly mapped, quantified, and associated with *in situ* dynamics



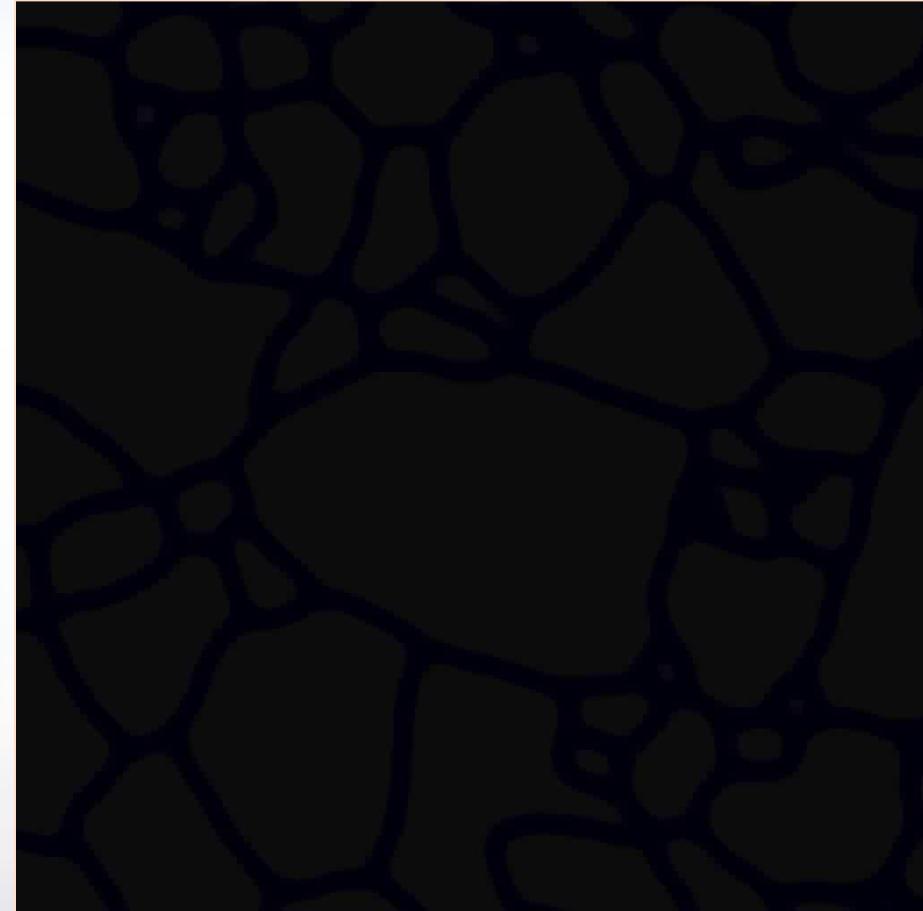
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Comparing Experimental and Modeling Dynamics

Collaborators: F. Abdeljawad, & S.M. Foiles



2 × real time



- Au foil during bombardment with 10 MeV Si^{3+}
- Approx. 22 s of 4000s total experiment time

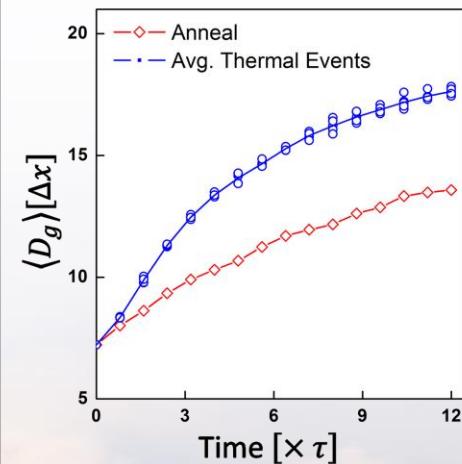
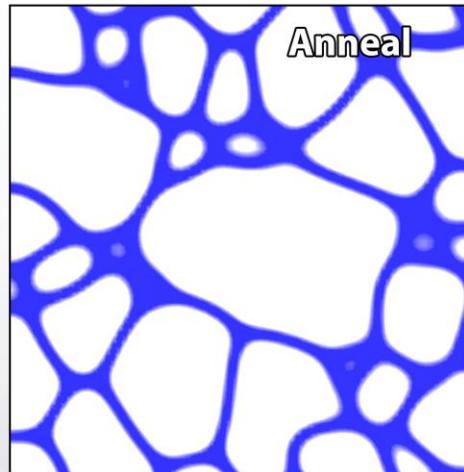
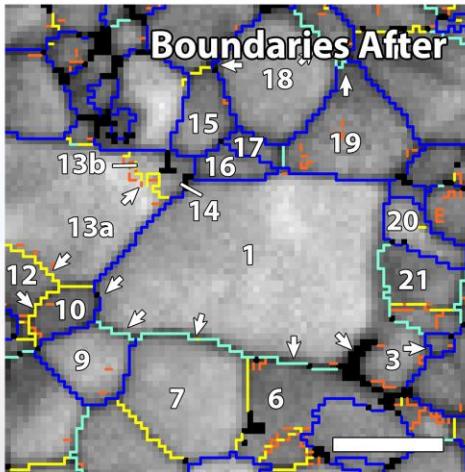
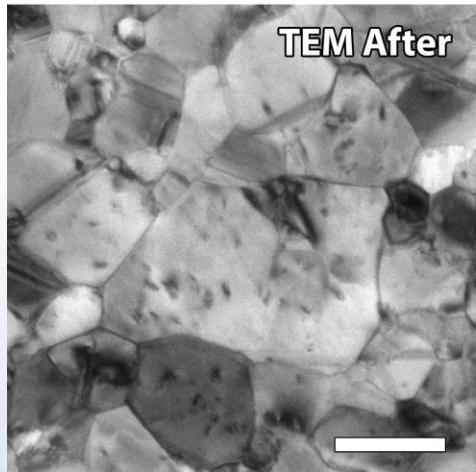
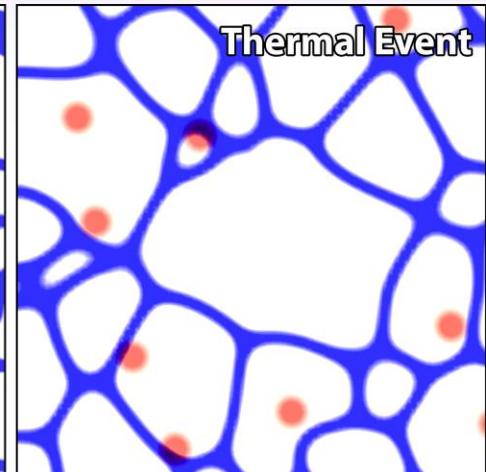
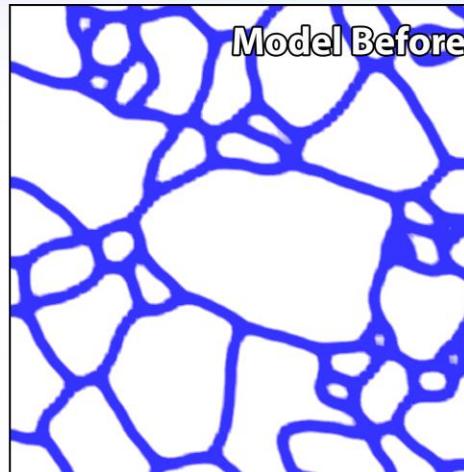
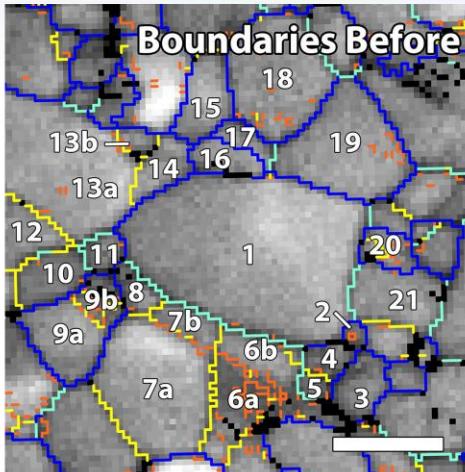
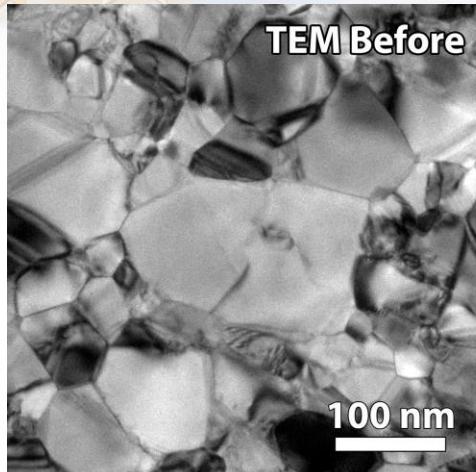
Dynamics do not match, but show many similar effects



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Direct Comparison to Mesoscale Modeling

Collaborators: F. Abdeljawad, & S.M. Foiles



Because of the matching length scale, the initial microstructure can serve as direct input to either MD or mesoscale models. Subsequent structural evolution can be directly compared.

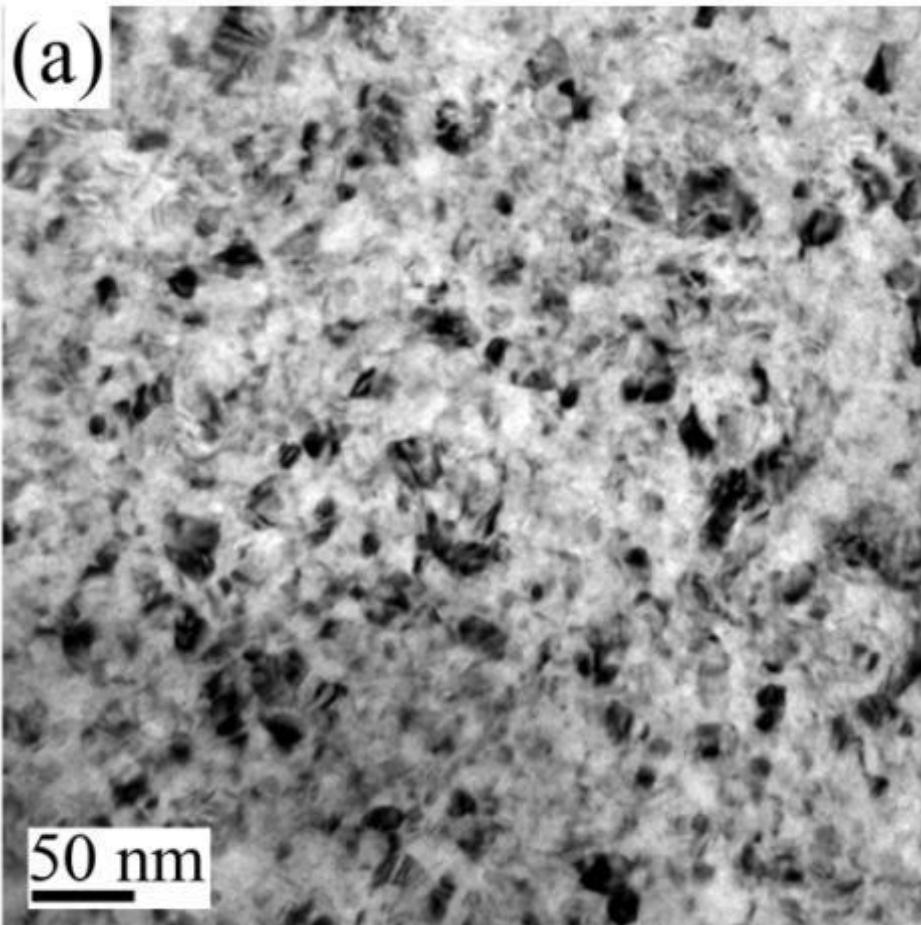


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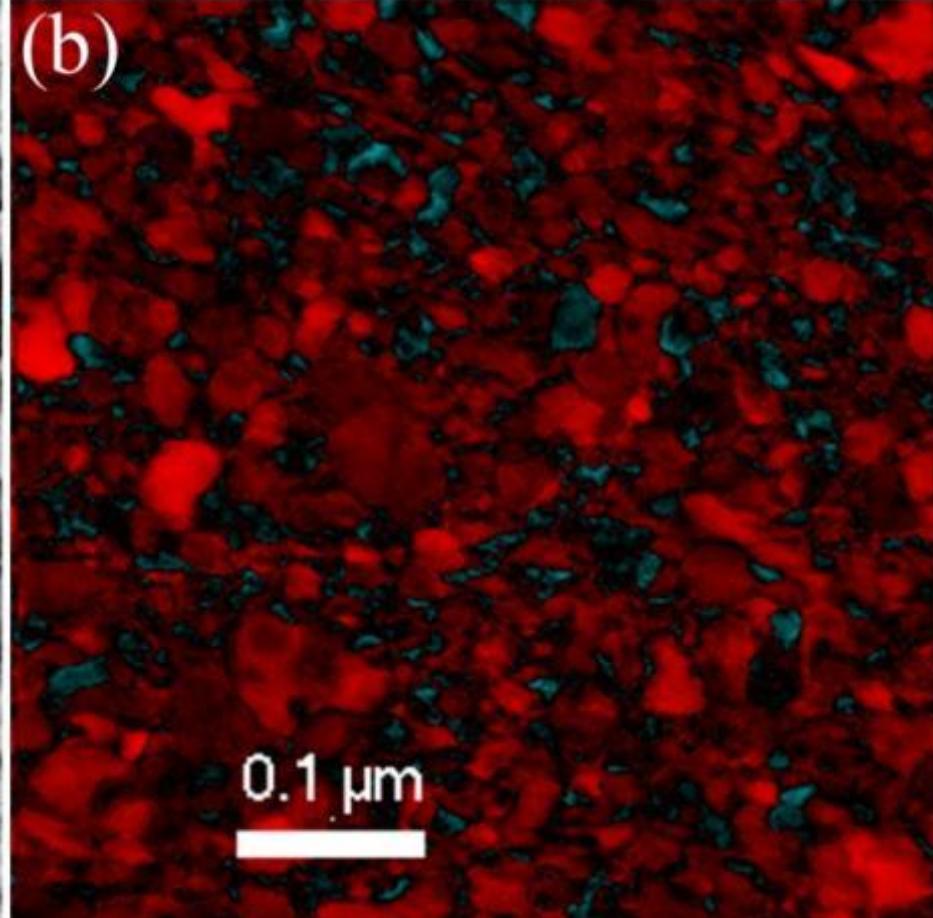
Phase Determination in 50 nm As-deposited Ni Film

Collaborators: P. Ferreira & S. Rajasekhara

BF – TEM



Re-constructed phase and reliability map



1,124 HCP phase grains (in $1.5 \mu\text{m}^2$)

Mean HCP grain size : $8.1 \pm 0.3 \text{ nm}$

Mean HCP phase percentage: 6.0%

Both FCC and HCP phase are present in as-deposited high purity PLD Ni films

■ FCC phase
■ HCP phase

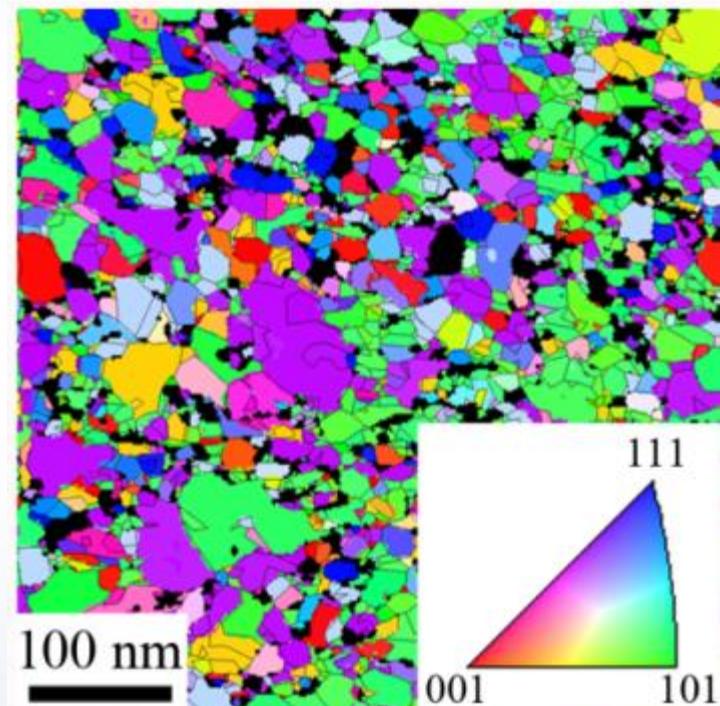


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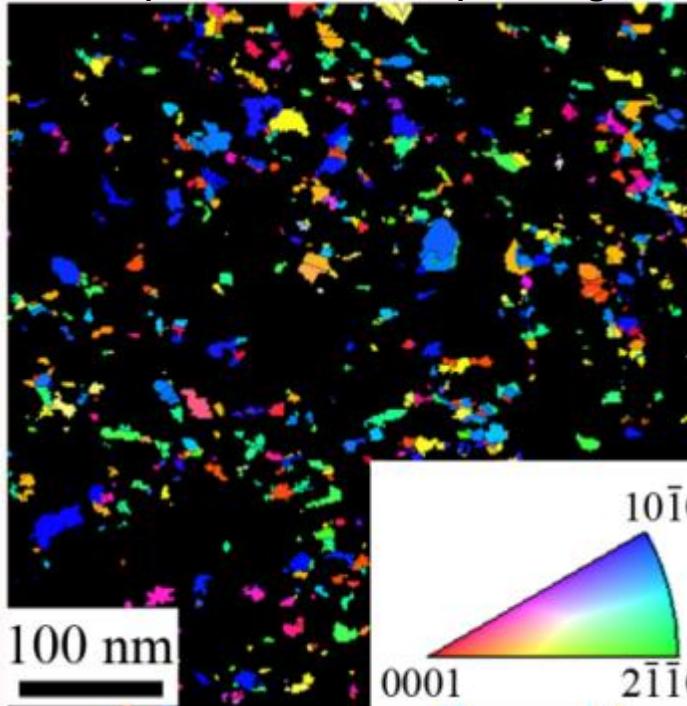
FCC and HCP Texture Determination in 50 nm As-deposited Ni Film

Collaborators: P. Ferreira & S. Rajasekharan

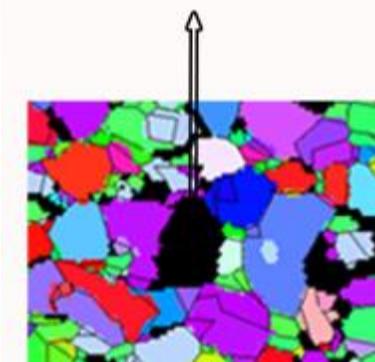
FCC phase inverse pole figure



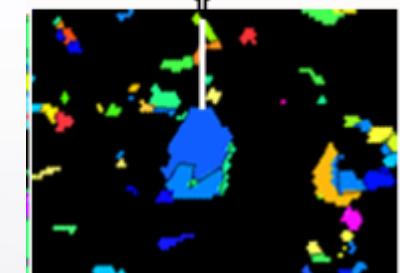
HCP phase inverse pole figure



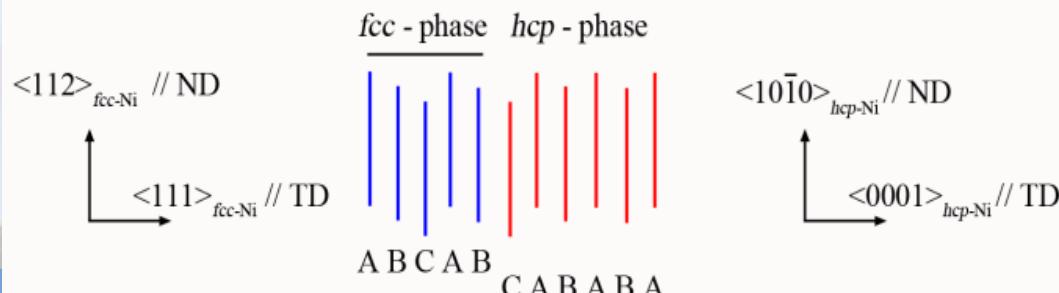
$<112>_{\text{fcc-Ni}} // \text{ND}$



$<1010>_{\text{hcp-Ni}} // \text{ND}$



Texture maps at the nanoscale obtained from a TEM
increase insight into abnormal grain growth



$<112>$ FCC-Ni // ND results in an in-plane
 $<111>$ FCC-Ni // TD

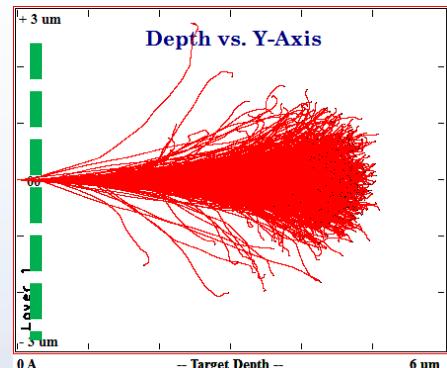
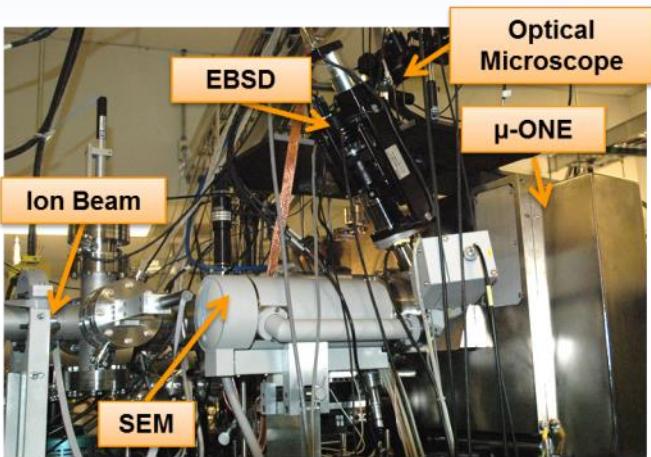
High energy PLD may introduce stacking
faults leading to a $<0001>$ HCP-Ni // TD



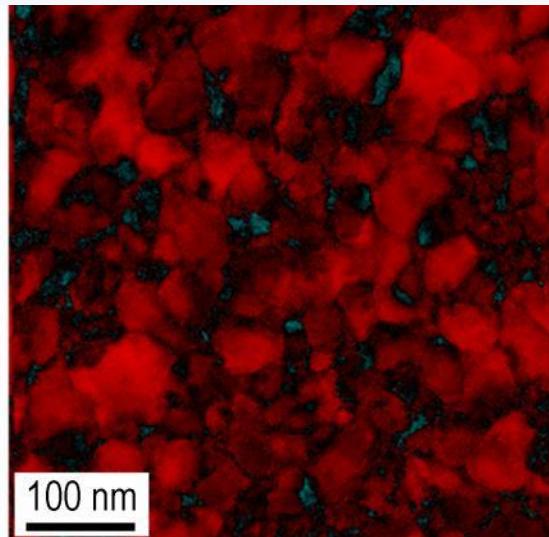
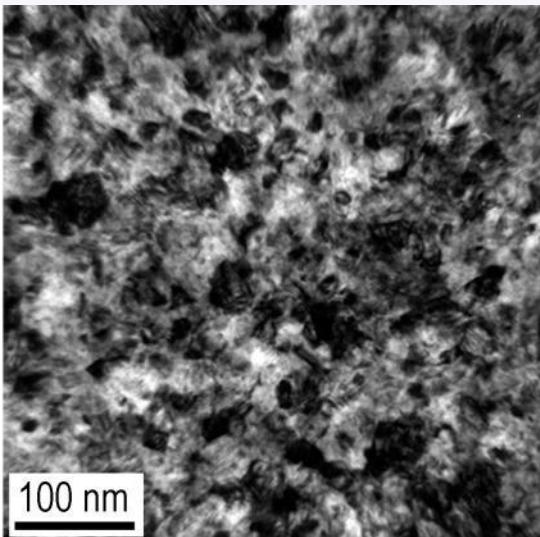
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FCC and HCP Phase Evolution after 35 MeV Ni Irradiation

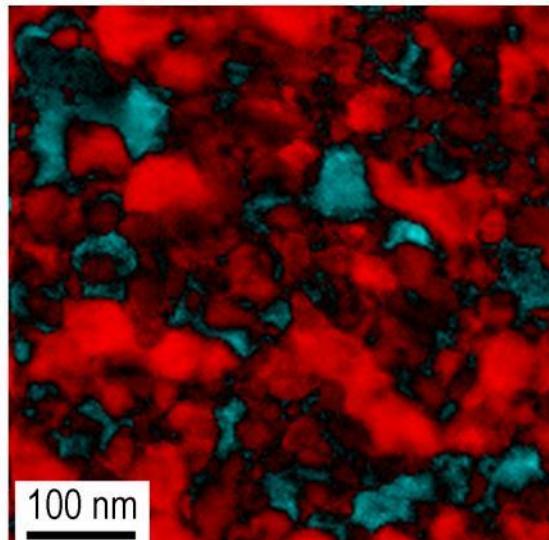
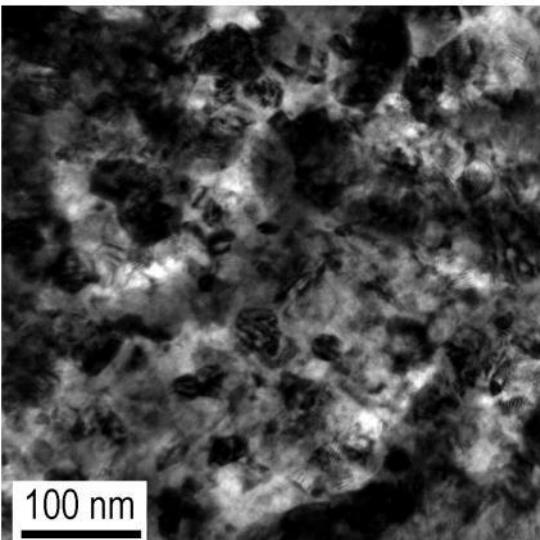
Collaborators: P. Ferreira & S. Rajasekhara



As-deposited



35 MeV Ni $3 \times 10^{14} \text{ cm}^{-2}$



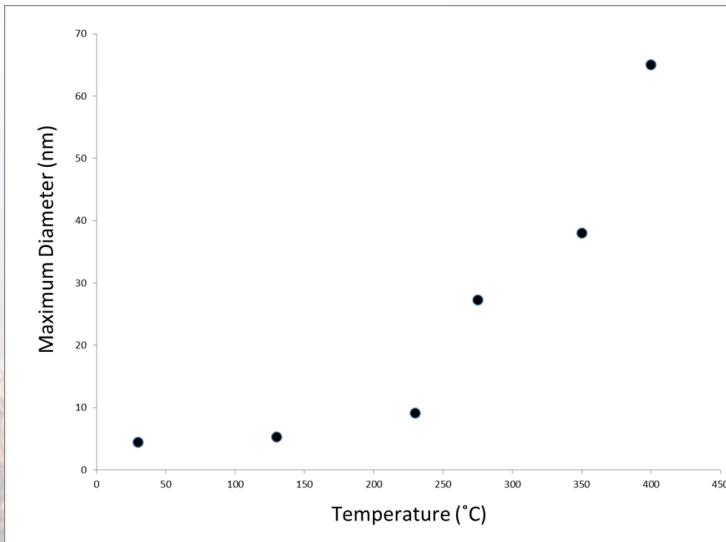
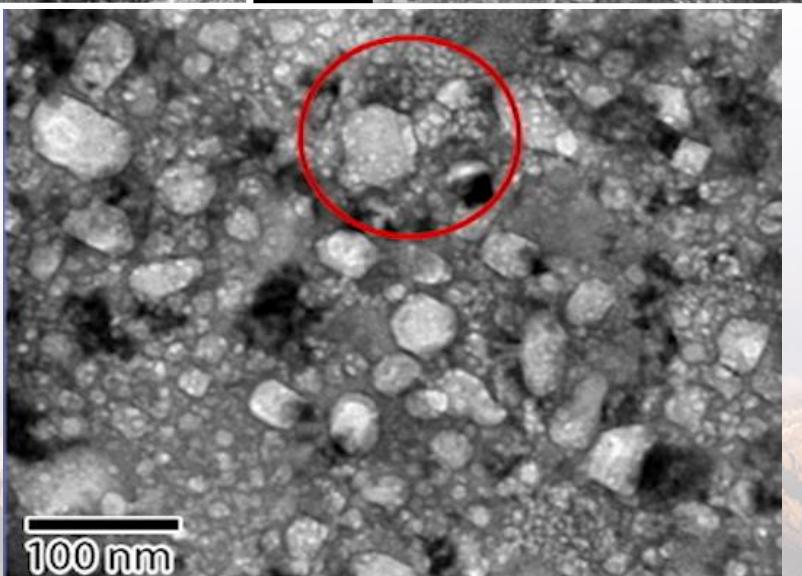
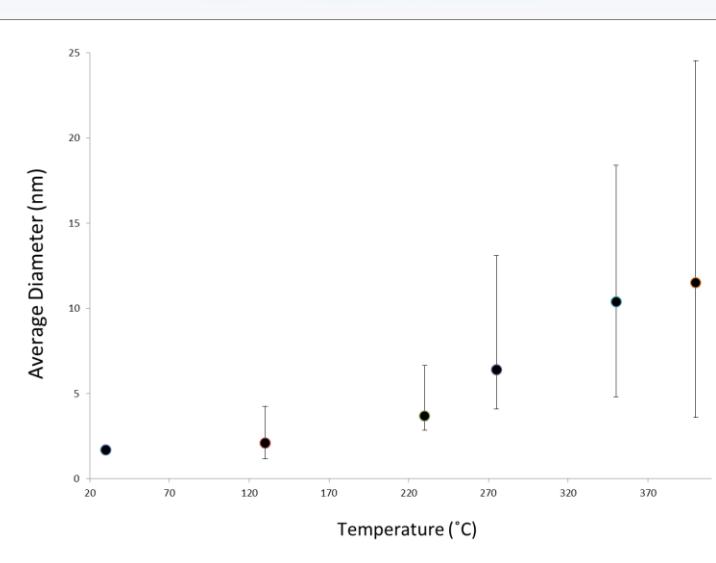
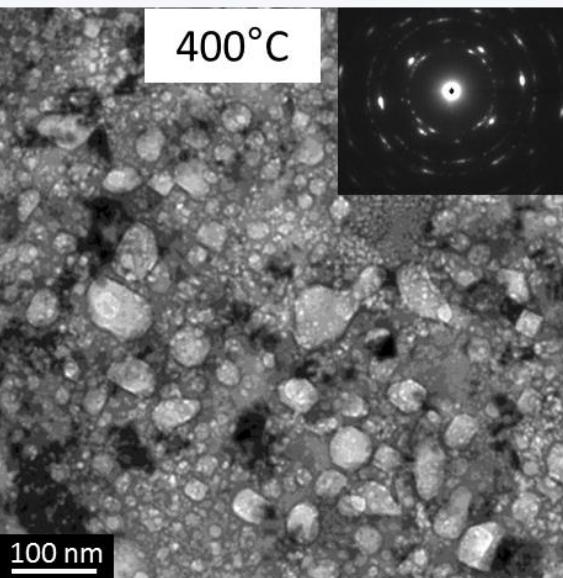
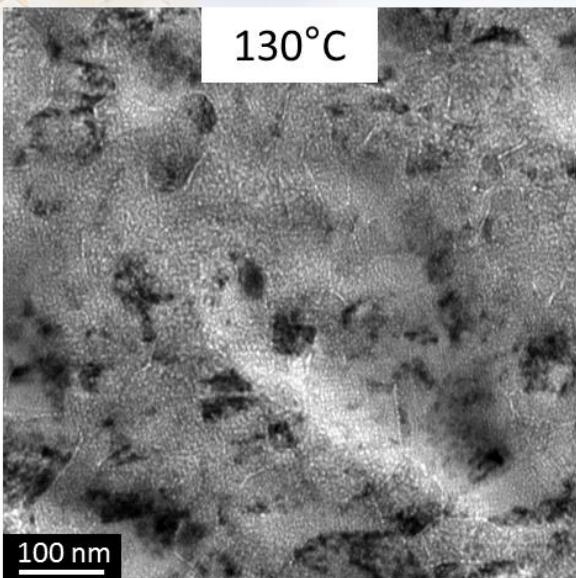
Despite the minimal interaction predicted in 100 nm film, grain growth was observed and increased HCP phase resulted

■ FCC phase ■ HCP phase



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Cavity Growth during In-situ Annealing of 10 keV He⁺ Implanted and then 3 MeV Irradiated Ni³⁺

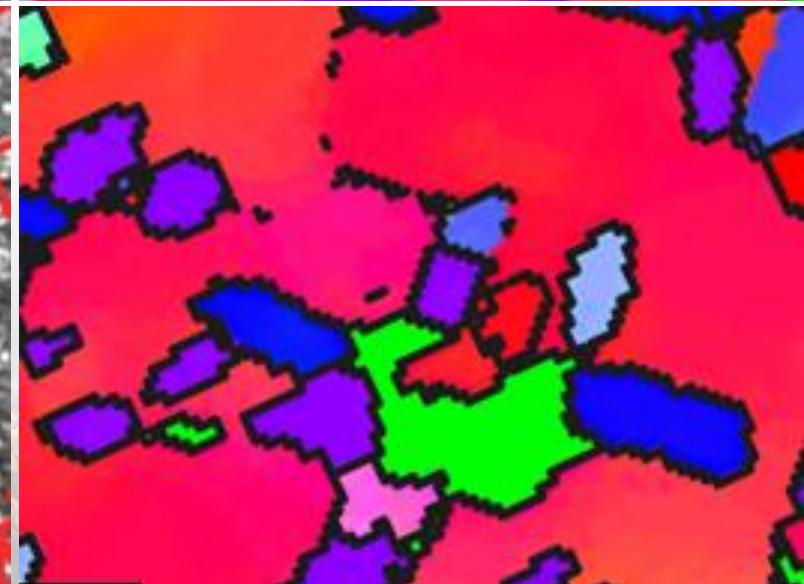
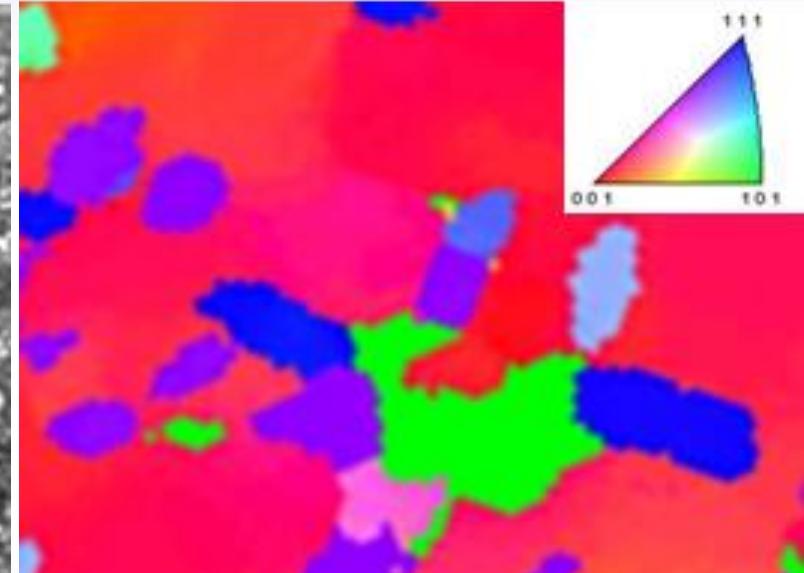
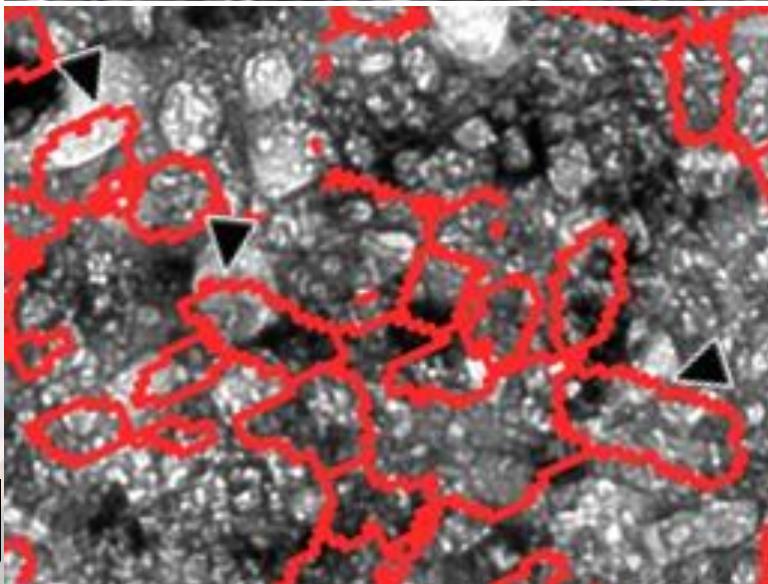
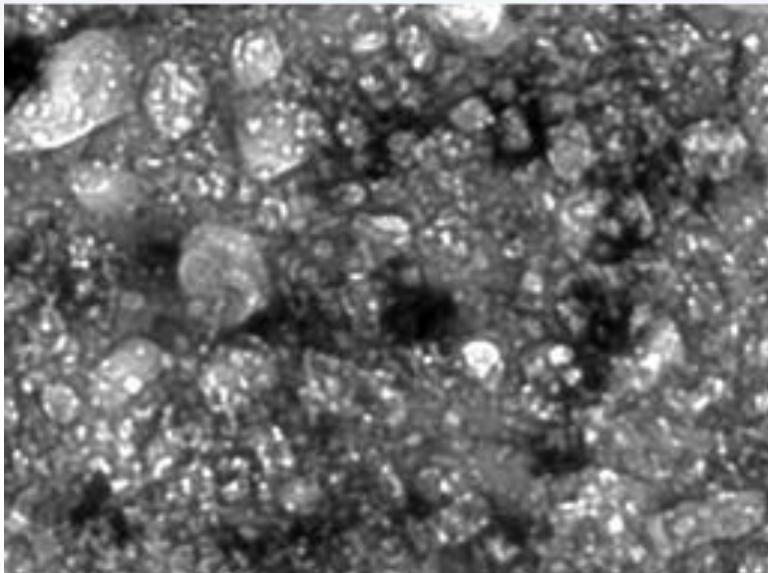




Precession Electron Diffraction Reveals Hidden Grain Structure

Cavities in helium implanted, self-ion irradiated, nc nickel film annealed to 400 °C

Cavities span multiple grains at identified grain boundaries



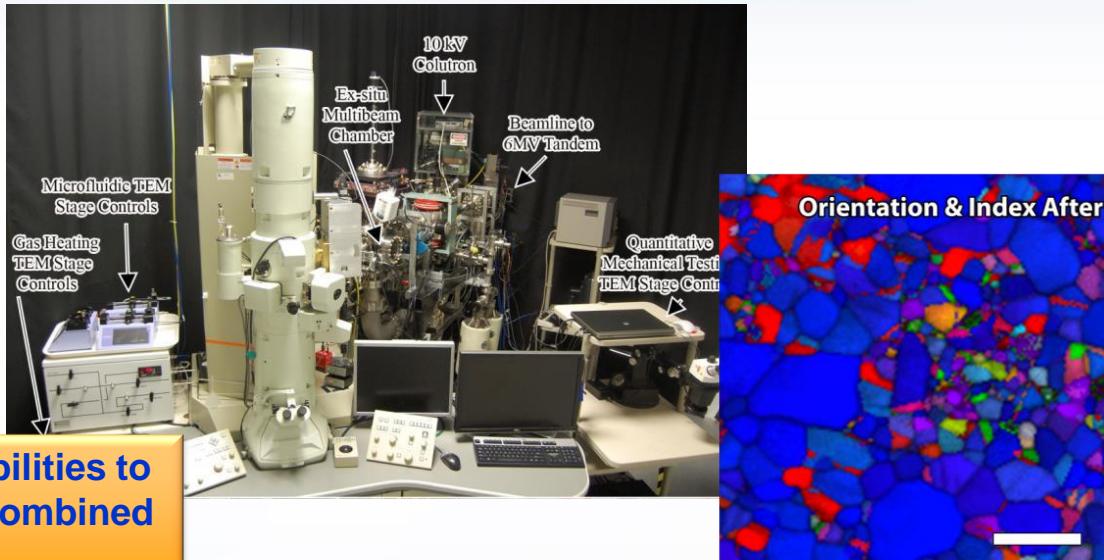
100 nm

Summary

Sandia's I³TEM capabilities:

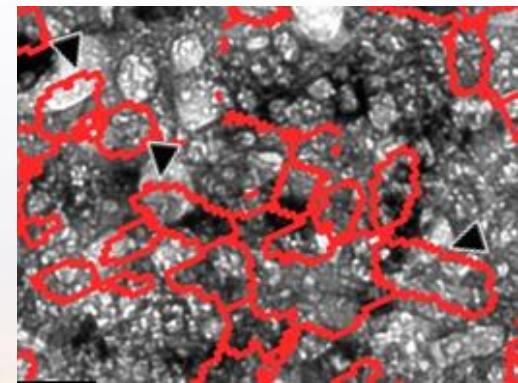
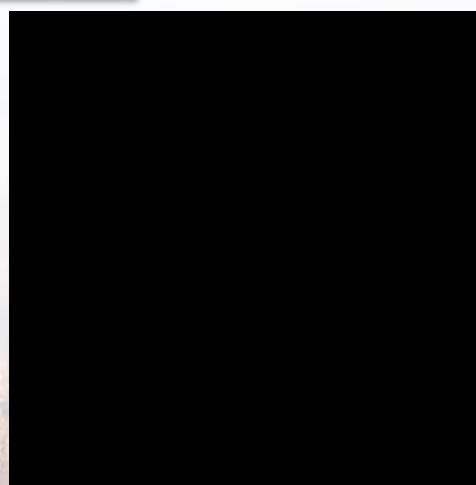
- *In situ* high energy ion irradiation from H to Au
- *In situ* gas implantation
- Heating up to 1,000 °C
- Quantitative and bulk straining
- Two-port microfluidic cell
- Gas flow/heating stage
- Electron tomography
- Precession Electron Diffraction

Currently applying the current I3TEM capabilities to various material systems in sequential or combined harsh environmental conditions



Structural response of metal sample to various harsh environments:

- Sequence of gas implantation and cascade formation matters for the final microstructure
- Concurrent gas implantation and irradiation permits the deconvolution of environmental parameters
- PED permits the correlation of bubble evolution with grain texture and boundary type
- Not limited to vacuum environments



This work was partially funded by the Division of Materials Science and Engineering, Office of Basic Energy Sciences, U.S. Department of Energy. Sandia National Laboratories is a multi-program laboratory managed and operated by Sandia Corporation, a wholly owned subsidiary of Lockheed Martin Corporation, for the U.S. Department of Energy's National Nuclear Security Administration under contract DE-AC04-94AL85000.



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